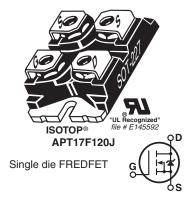




1200V, 18A, 0.58 Ω Max, $t_{rr} \le$ 330ns

N-Channel FREDFET

POWER MOS 8® is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced t_{rr} , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C_{rss}/C_{iss} result in excellent niose immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



FEATURES

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- · ZVS phase shifted and other full full bridge
- · Half bridge
- PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
I _D	Continuous Drain Current @ T _C = 25°C	18	
	Continuous Drain Current @ T _C = 100°C	12	Α
I _{DM}	Pulsed Drain Current ^①	104	
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy®	2165	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	14	Α

Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit	
P _D	Total Power Dissipation @ T _C = 25°C			545	W	
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.23 °C/W		
$R_{\theta CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15			
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55		150	°C	
V _{Isolation}	RMS Voltage (50-60hHz Sinusoidal Wavefomr from Terminals to Mounting Base for 1 Min.)	2500			V	
W _T	Package Weight		1.03		OZ	
			29.2		g	
Torque	Terminals and Mounting Screws.			10	in∙lbf	
				1.1	N⋅m	

Static Characteristics

T_J = 25°C unless otherwise specified

Δ	P1	Г1	7	F1	2	N.
\rightarrow			•	ГΙ		Uu

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250\mu A$	1200			V
$\Delta V_{BR(DSS)}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_D = 250\mu A$		1.41		V/°C
R _{DS(on)}	Drain-Source On Resistance [®]	$V_{GS} = 10V, I_{D} = 14A$		0.55	0.58	Ω
V _{GS(th)}	Gate-Source Threshold Voltage	\/ -\/ -2.5m/	2.5	4	5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_D = 2.5 \text{mA}$		-10		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 1200V$ $T_{J} = 25^{\circ}C$			250	μA
		$V_{GS} = 0V$ $T_J = 125^{\circ}C$			1000	μΑ
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			±100	nA

Dvnamic Characteristics

T_{.1} = 25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
9 _{fs}	Forward Transconductance	$V_{DS} = 50V, I_{D} = 14A$		31		S
C _{iss}	Input Capacitance	V 0V V 05V		9670		
C_{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		115		
C _{oss}	Output Capacitance	7 - 111112		715		
$C_{o(cr)} \textcircled{4}$	Effective Output Capacitance, Charge Related	V 9V V 9V 999V		275		pF
C _{o(er)} ⑤	Effective Output Capacitance, Energy Related	V _{GS} = 0V, V _{DS} = 0V to 800V		140		
Q _g	Total Gate Charge	V 01 10V 1 11A		300		
Q_{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 14A,$		50		nC
Q_{gd}	Gate-Drain Charge	$V_{DS} = 600V$		140		
t _{d(on)}	Turn-On Delay Time	Resistive Switching		50		
t _r	Current Rise Time	V _{DD} = 800V, I _D = 14A		31		ns
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 2.2\Omega^{\textcircled{6}}, V_{GG} = 15V$		170		115
t _f	Current Fall Time]		48		

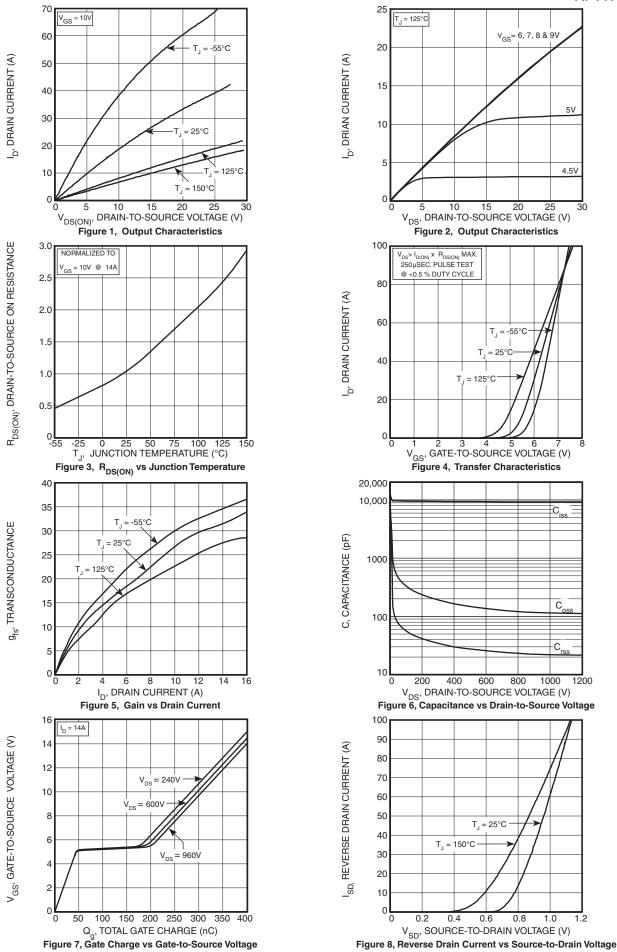
Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Is	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n			18	A
I _{SM}	Pulsed Source Current (Body Diode) ^①	junction diode (body diode)	os s		104	A
V _{SD}	Diode Forward Voltage	$I_{SD} = 14A, T_{J} = 25^{\circ}C, V_{GS} = 14A$	0V		1.1	V
t _{rr}	Reverse Recovery Time	T _J = 25°C	;		330	ns
rr		T _J = 125°	C		660	115
Q _{rr}	Reverse Recovery Charge	$I_{SD} = 14A^{\textcircled{3}}$ $T_{J} = 25^{\circ}C$		1.72		μC
rr		$di_{SD}/dt = 100A/\mu s$ $T_J = 125^{\circ}C$	C	4.67		μΟ
	Reverse Recovery Current	T _J = 25°C	;	11		Α
'rrm	neverse necovery Current	T _J = 125°	C	16		^
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 14A$, di/dt $\le 1000A/\mu s$, $V_{DD} = 1$ $T_J = 125^{\circ}C$	00V,		25	V/ns

- 1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_J = 25$ °C, L = 22.1mH, $R_G = 25\Omega$, $I_{AS} = 14$ A.
- (3) Pulse test: Pulse Width < 380µs, duty cycle < 2%.

- (6) R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.



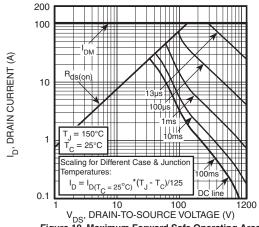
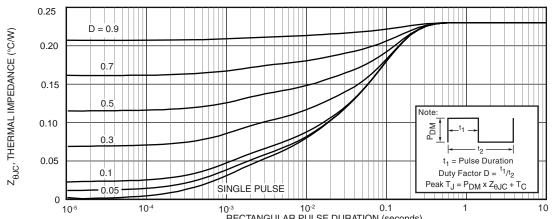


Figure 10, Maximum Forward Safe Operating Area



RECTANGULAR PULSE DURATION (seconds)
Figure 11. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

SOT-227 (ISOTOP®) Package Outline 11.8 (.463) 12.2 (.480) 31.5 (1.240) 31.7 (1.248) 8.9 (.350) 9.6 (.378) 7.8 (.307) 8.2 (.322) W=4.1 (.161) W=4.3 (.169) H=4.8 (.187) H=4.9 (.193) Hex Nut M4 (4 places) (4 places) 0.75 (.030) 12.6 (.496) 25.4 (1.000) 12.8 (.504) r = 4.0 (.157) (2 places) 4.0 (.157) 4.2 (.165) (2 places) 3.3 (.129) 3.6 (.143) 1.95 (.077) 2.14 (.084) 14.9 (.587) 15.1 (.594) * Source .30.1 (1.185) 30.3 (1.193) Emitter terminals are shorted internally. Current handling capability is equal for either Source terminal. 38.0 (1.496) 38.2 (1.504) * Source Gate

Dimensions in Millimeters and (Inches)